

## General Description

The QM04N65F1 is the highest performance N-ch MOSFETs with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The QM04N65F1 meet the RoHS and Green Product requirement , 100% EAS guaranteed with full function reliability approved.

## Features

- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

## Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	650	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	4	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	2.6	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	8	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	26.2	mJ
$I_{AS}$	Avalanche Current	7	A
$P_D @ T_C = 25^\circ C$	Total Power Dissipation <sup>4</sup>	41.6	W
$T_{STG}$	Storage Temperature Range	-55 to 150	°C
$T_J$	Operating Junction Temperature Range	-55 to 150	°C

## Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient (Steady State) <sup>1</sup>	---	62	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case <sup>1</sup>	---	3	°C/W

## Product Summary

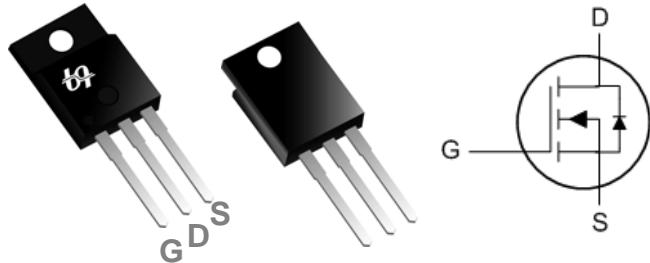


BVDSS	RDS(on)	ID
650V	2.6 Ω	4A

## Applications

- High efficient switched mode power supplies
- Electronic lamp ballast
- LCD TV/ Monitor
- Adapter

## TO220FL Pin Configuration



**Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}$ , $I_D=250\mu\text{A}$	650	---	---	V
$\Delta BV_{DSS}/\Delta T_J$	$BV_{DSS}$ Temperature Coefficient	Reference to $25^\circ\text{C}$ , $I_D=1\text{mA}$	---	0.69	---	$\text{V}/^\circ\text{C}$
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance <sup>2</sup>	$V_{GS}=10\text{V}$ , $I_D=2\text{A}$	---	2.1	2.6	$\Omega$
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=250\mu\text{A}$	2	---	5	V
$\Delta V_{GS(\text{th})}$	$V_{GS(\text{th})}$ Temperature Coefficient	$V_{GS}=V_{DS}$ , $I_D=250\mu\text{A}$	---	-8.2	---	$\text{mV}/^\circ\text{C}$
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=520\text{V}$ , $V_{GS}=0\text{V}$ , $T_J=25^\circ\text{C}$	---	---	2	$\mu\text{A}$
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=\pm 30\text{V}$ , $V_{DS}=0\text{V}$	---	---	$\pm 100$	nA
$g_{fs}$	Forward Transconductance	$V_{DS}=15\text{V}$ , $I_D=2\text{A}$	---	3	---	S
$R_g$	Gate Resistance	$V_{DS}=0\text{V}$ , $V_{GS}=0\text{V}$ , $f=1\text{MHz}$	---	3.4	6.8	$\Omega$
$Q_g$	Total Gate Charge (10V)		---	18	---	nC
$Q_{gs}$	Gate-Source Charge	$V_{DS}=520\text{V}$ , $V_{GS}=10\text{V}$ , $I_D=1\text{A}$	---	4.9	---	
$Q_{gd}$	Gate-Drain Charge		---	6.1	---	
$T_{d(on)}$	Turn-On Delay Time		---	11.2	---	ns
$T_r$	Rise Time	$V_{DD}=300\text{V}$ , $V_{GS}=10\text{V}$ , $R_G=10\Omega$ ,	---	18.8	---	
$T_{d(off)}$	Turn-Off Delay Time	$I_D=1\text{A}$	---	29.2	---	
$T_f$	Fall Time		---	29.2	---	
$C_{iss}$	Input Capacitance		---	775	---	pF
$C_{oss}$	Output Capacitance	$V_{DS}=25\text{V}$ , $V_{GS}=0\text{V}$ , $F=1\text{MHz}$	---	56	---	
$C_{rss}$	Reverse Transfer Capacitance		---	3.8	---	

**Guaranteed Avalanche Characteristics**

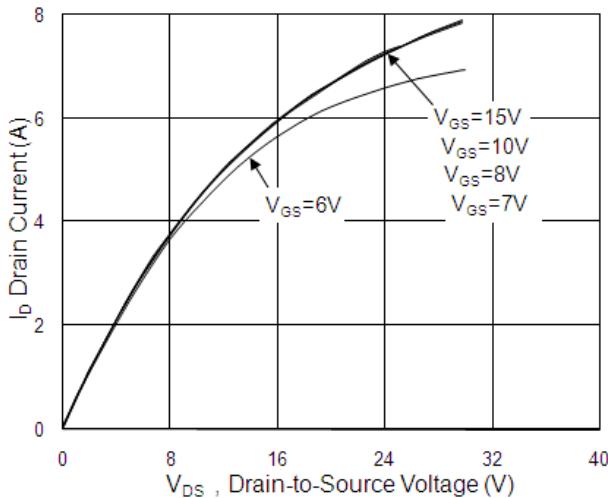
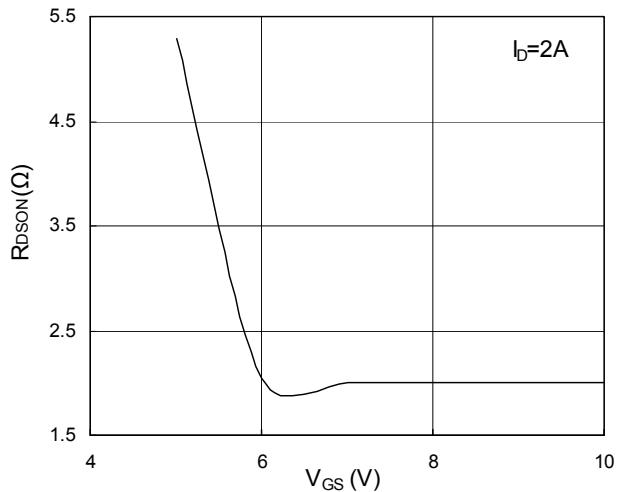
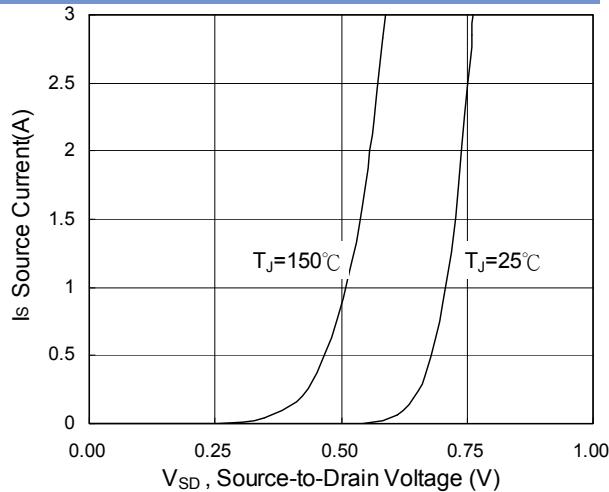
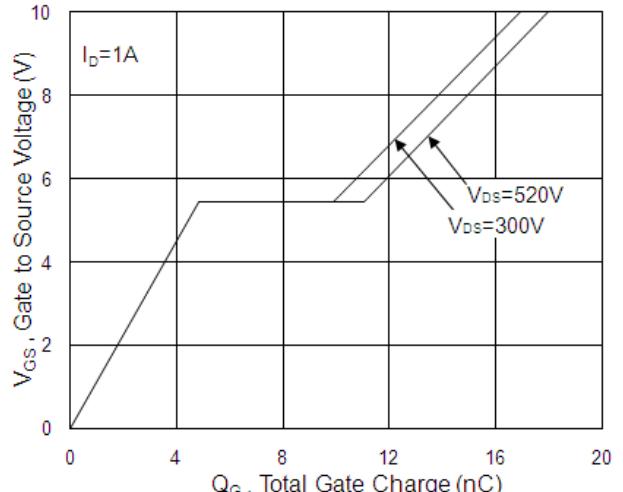
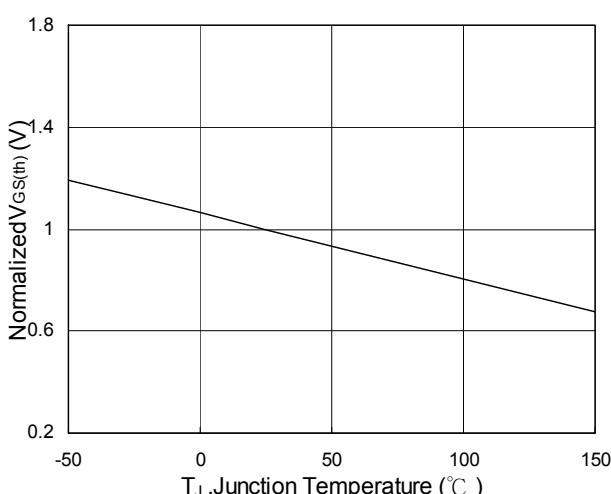
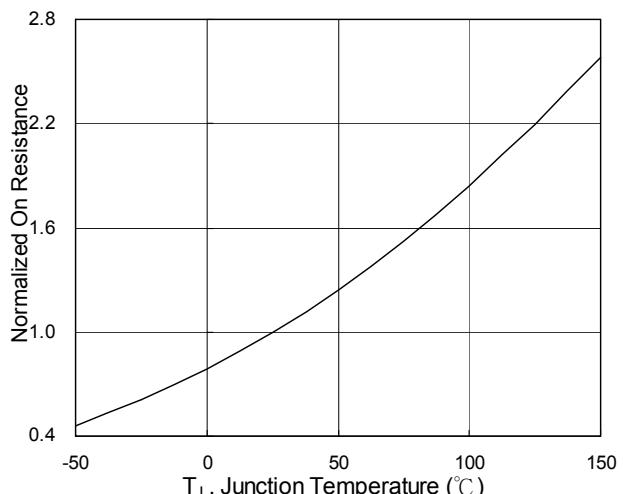
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
EAS	Single Pulse Avalanche Energy <sup>5</sup>	$V_{DD}=50\text{V}$ , $L=1\text{mH}$ , $I_{AS}=4\text{A}$	8.6	---	---	mJ

**Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_s$	Continuous Source Current <sup>1,6</sup>	$V_G=V_D=0\text{V}$ , Force Current	---	---	4	A
$I_{SM}$	Pulsed Source Current <sup>2,6</sup>		---	---	8	A
$V_{SD}$	Diode Forward Voltage <sup>2</sup>	$V_{GS}=0\text{V}$ , $I_s=1\text{A}$ , $T_J=25^\circ\text{C}$	---	---	1	V
$t_{rr}$	Reverse Recovery Time		---	195	---	nS
$Q_{rr}$	Reverse Recovery Charge	$I_F=1\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$ , $T_J=25^\circ\text{C}$	---	580	---	nC

Note :

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is  $V_{DD}=50\text{V}$ ,  $V_{GS}=10\text{V}$ ,  $L=1\text{mH}$ ,  $I_{AS}=7\text{A}$
- 4.The power dissipation is limited by  $150^\circ\text{C}$  junction temperature
- 5.The Min. value is 100% EAS tested guarantee.
- 6.The data is theoretically the same as  $I_D$  and  $I_{DM}$  , in real applications , should be limited by total power dissipation.

**Typical Characteristics**

**Fig.1 Typical Output Characteristics**

**Fig.2 On-Resistance vs. G-S Voltage**

**Fig.3 Forward Characteristics of Reverse**

**Fig.4 Gate-Charge Characteristics**

**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$** 

**Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$**

